



**ALPHA & OMEGA**  
SEMICONDUCTOR

**AOT12N40**  
**400V, 11A N-Channel MOSFET**

### General Description

The AOT12N40 is fabricated using an advanced high voltage MOSFET process that is designed to deliver high levels of performance and robustness in popular AC-DC applications. By providing low  $R_{DS(on)}$ ,  $C_{iss}$  and  $C_{rss}$  along with guaranteed avalanche capability this part can be adopted quickly into new and existing offline power supply designs.

For Halogen Free add "L" suffix to part number:  
AOT12N40L

### Product Summary

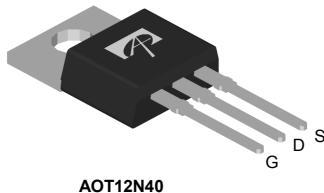
$V_{DS}$	500V@150°C
$I_D$ (at $V_{GS}=10V$ )	11A
$R_{DS(ON)}$ (at $V_{GS}=10V$ )	<0.59Ω

100% UIS Tested  
100%  $R_g$  Tested

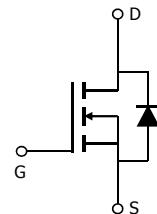


Top View

TO-220



AOT12N40



### Absolute Maximum Ratings $T_A=25^\circ\text{C}$ unless otherwise noted

Parameter	Symbol	Maximum	Units
Drain-Source Voltage	$V_{DS}$	400	V
Gate-Source Voltage	$V_{GS}$	$\pm 30$	V
Continuous Drain Current	$I_D$	11	A
$T_C=100^\circ\text{C}$	$I_D$	7	
Pulsed Drain Current <sup>C</sup>	$I_{DM}$	28	A
Avalanche Current <sup>C</sup>	$I_{AR}$	3.5	A
Repetitive avalanche energy <sup>C</sup>	$E_{AR}$	184	mJ
Single pulsed avalanche energy <sup>G</sup>	$E_{AS}$	368	mJ
Peak diode recovery dv/dt	dv/dt	5	V/ns
Power Dissipation <sup>B</sup>	$P_D$	184	W
Derate above $25^\circ\text{C}$	$P_D$	1.5	W/ °C
Junction and Storage Temperature Range	$T_J, T_{STG}$	-55 to 150	°C
Maximum lead temperature for soldering purpose, 1/8" from case for 5 seconds	$T_L$	300	°C

### Thermal Characteristics

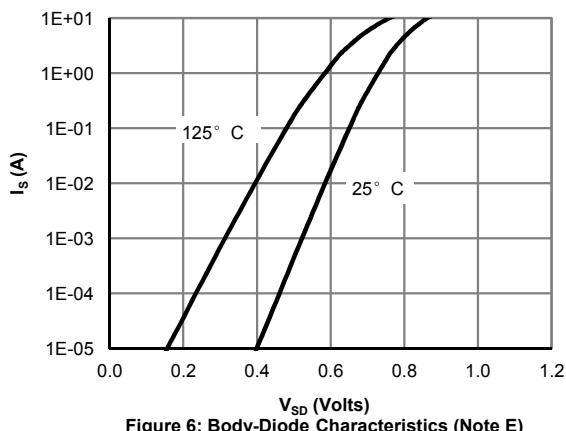
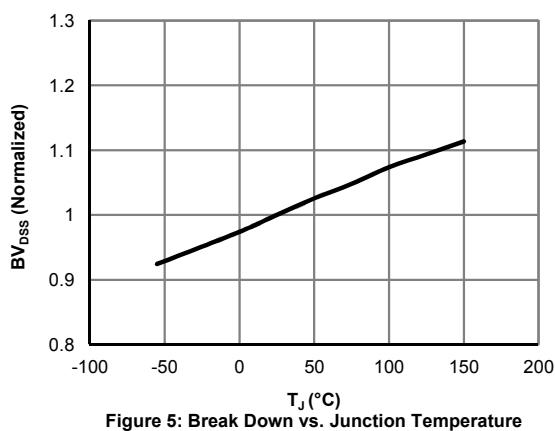
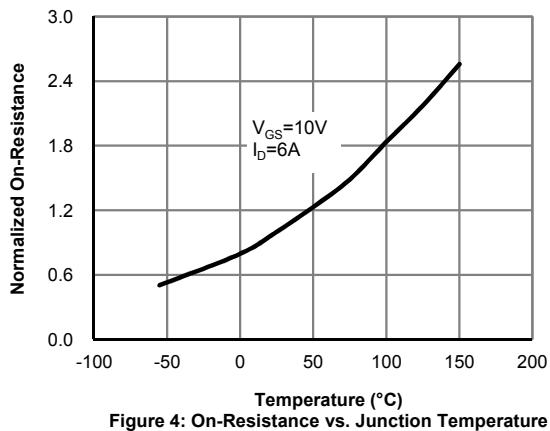
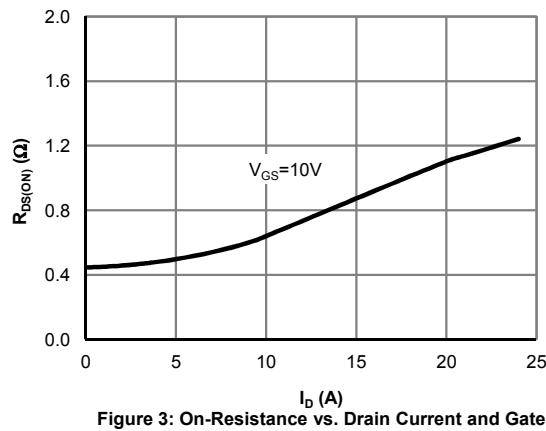
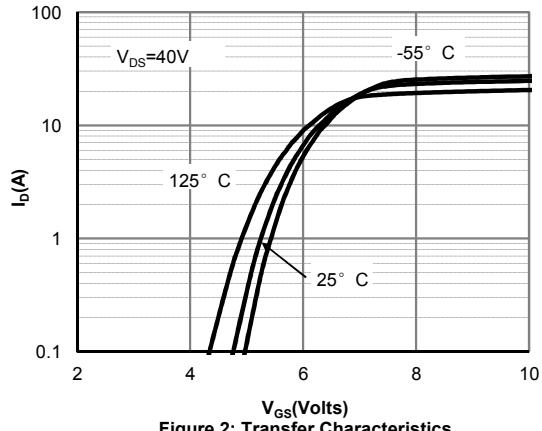
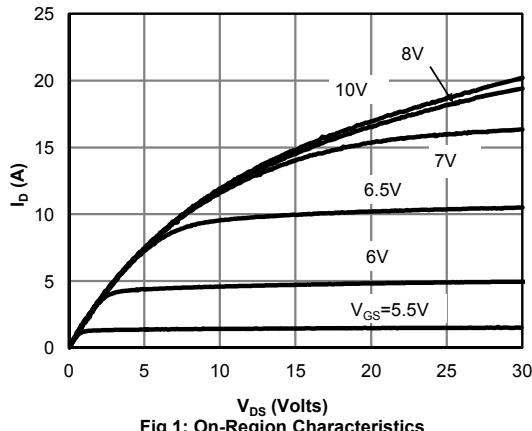
Parameter	Symbol	Typical	Maximum	Units
Maximum Junction-to-Ambient <sup>A,D</sup>	$R_{\theta JA}$	54	65	°C/W
Maximum Case-to-sink <sup>A</sup>	$R_{\theta CS}$	-	0.5	°C/W
Maximum Junction-to-Case	$R_{\theta JC}$	0.56	0.68	°C/W

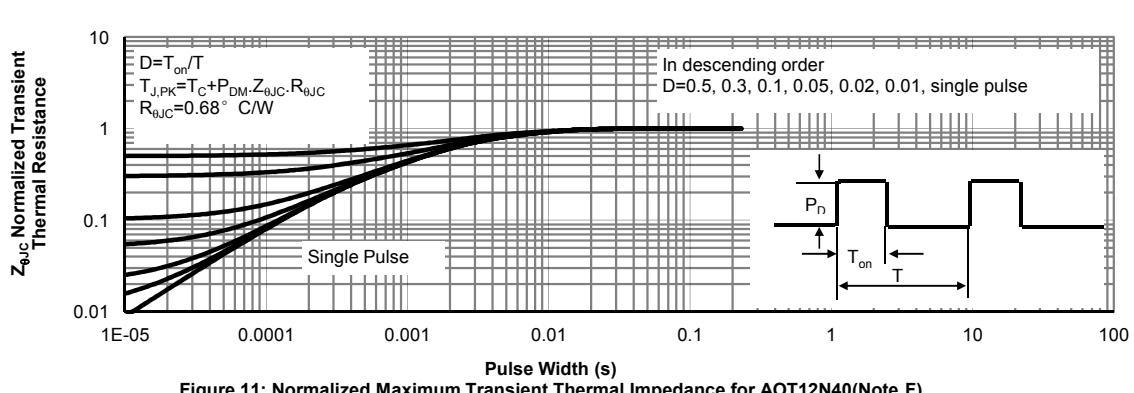
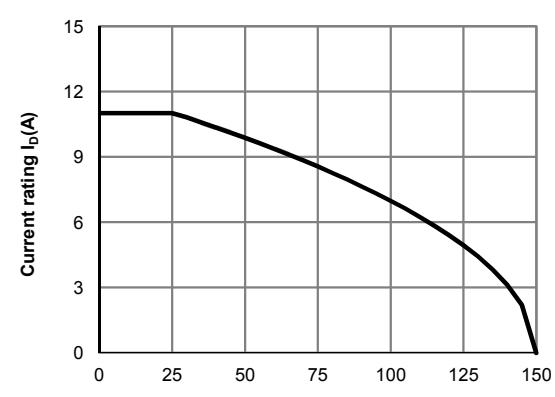
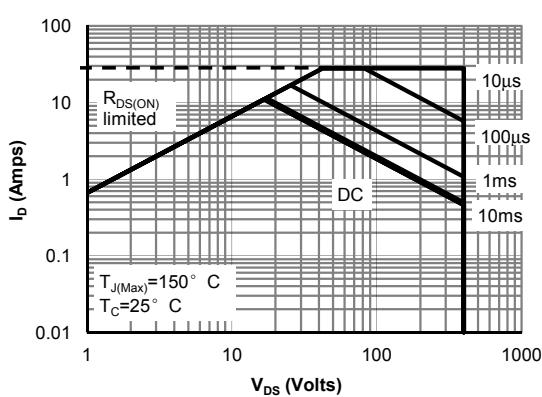
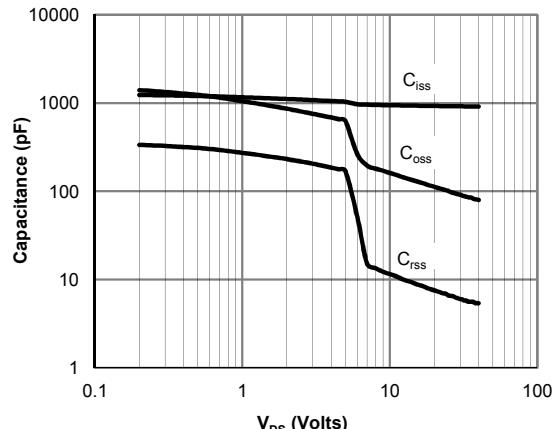
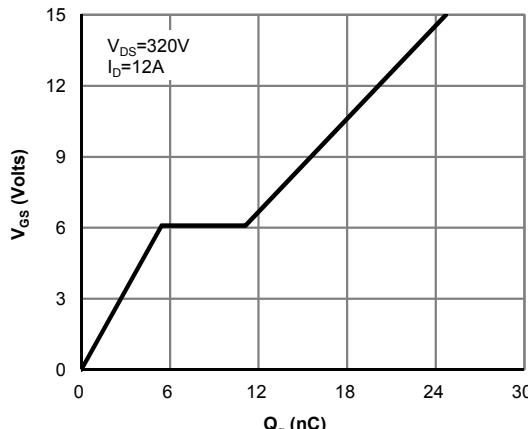
**Electrical Characteristics ( $T_J=25^\circ\text{C}$  unless otherwise noted)**

Symbol	Parameter	Conditions	Min	Typ	Max	Units
<b>STATIC PARAMETERS</b>						
BV <sub>DSS</sub>	Drain-Source Breakdown Voltage	I <sub>D</sub> =250μA, V <sub>GS</sub> =0V, T <sub>J</sub> =25°C	400			V
		I <sub>D</sub> =250μA, V <sub>GS</sub> =0V, T <sub>J</sub> =150°C		500		
BV <sub>DSS</sub> / $\Delta T_J$	Zero Gate Voltage Drain Current	I <sub>D</sub> =250μA, V <sub>GS</sub> =0V		0.4		V/°C
I <sub>DSS</sub>	Zero Gate Voltage Drain Current	V <sub>DS</sub> =400V, V <sub>GS</sub> =0V			1	μA
		V <sub>DS</sub> =320V, T <sub>J</sub> =125°C			10	
I <sub>GSS</sub>	Gate-Body leakage current	V <sub>DS</sub> =0V, V <sub>GS</sub> =±30V			±100	nA
V <sub>GS(th)</sub>	Gate Threshold Voltage	V <sub>DS</sub> =5V, I <sub>D</sub> =250μA	3.3	3.9	4.5	V
R <sub>DS(ON)</sub>	Static Drain-Source On-Resistance	V <sub>GS</sub> =10V, I <sub>D</sub> =6A		0.49	0.59	Ω
g <sub>FS</sub>	Forward Transconductance	V <sub>DS</sub> =40V, I <sub>D</sub> =6A		10		S
V <sub>SD</sub>	Diode Forward Voltage	I <sub>S</sub> =1A, V <sub>GS</sub> =0V		0.72	1	V
I <sub>S</sub>	Maximum Body-Diode Continuous Current				11	A
I <sub>SM</sub>	Maximum Body-Diode Pulsed Current				28	A
<b>DYNAMIC PARAMETERS</b>						
C <sub>iss</sub>	Input Capacitance	V <sub>GS</sub> =0V, V <sub>DS</sub> =25V, f=1MHz	740	925	1110	pF
C <sub>oss</sub>	Output Capacitance		70	100	130	pF
C <sub>rss</sub>	Reverse Transfer Capacitance		3.5	6.4	9.0	pF
R <sub>g</sub>	Gate resistance	V <sub>GS</sub> =0V, V <sub>DS</sub> =0V, f=1MHz	1.4	2.9	4.5	Ω
<b>SWITCHING PARAMETERS</b>						
Q <sub>g</sub>	Total Gate Charge	V <sub>GS</sub> =10V, V <sub>DS</sub> =320V, I <sub>D</sub> =12A	13	17	21	nC
Q <sub>gs</sub>	Gate Source Charge			5.4		nC
Q <sub>gd</sub>	Gate Drain Charge			5.7		nC
t <sub>D(on)</sub>	Turn-On DelayTime	V <sub>GS</sub> =10V, V <sub>DS</sub> =200V, I <sub>D</sub> =12A, R <sub>G</sub> =25Ω		25		ns
t <sub>r</sub>	Turn-On Rise Time			57		ns
t <sub>D(off)</sub>	Turn-Off DelayTime			41		ns
t <sub>f</sub>	Turn-Off Fall Time			32		ns
t <sub>rr</sub>	Body Diode Reverse Recovery Time	I <sub>F</sub> =12A, dI/dt=100A/μs, V <sub>DS</sub> =100V	180	235	290	ns
Q <sub>rr</sub>	Body Diode Reverse Recovery Charge	I <sub>F</sub> =12A, dI/dt=100A/μs, V <sub>DS</sub> =100V	1.9	2.4	2.9	μC

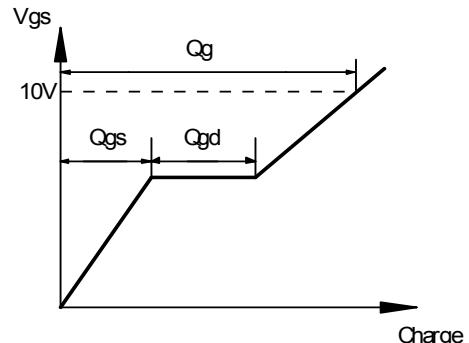
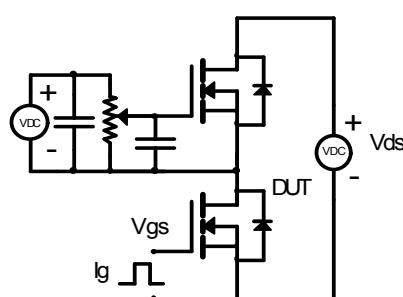
- A. The value of R<sub>θJA</sub> is measured with the device in a still air environment with T<sub>A</sub>=25°C.  
 B. The power dissipation P<sub>D</sub> is based on T<sub>J(MAX)=150°C</sub>, using junction-to-case thermal resistance, and is more useful in setting the upper dissipation limit for cases where additional heatsinking is used.  
 C. Repetitive rating, pulse width limited by junction temperature T<sub>J(MAX)=150°C</sub>. Ratings are based on low frequency and duty cycles to keep initial T<sub>J</sub>=25°C.  
 D. The R<sub>θJA</sub> is the sum of the thermal impedance from junction to case R<sub>θJC</sub> and case to ambient.  
 E. The static characteristics in Figures 1 to 6 are obtained using <300 μs pulses, duty cycle 0.5% max.  
 F. These curves are based on the junction-to-case thermal impedance which is measured with the device mounted to a large heatsink, assuming a maximum junction temperature of T<sub>J(MAX)=150°C</sub>. The SOA curve provides a single pulse rating.  
 G. L=60mH, I<sub>AS</sub>=3.5A, V<sub>DD</sub>=150V, R<sub>G</sub>=25Ω, Starting T<sub>J</sub>=25°C

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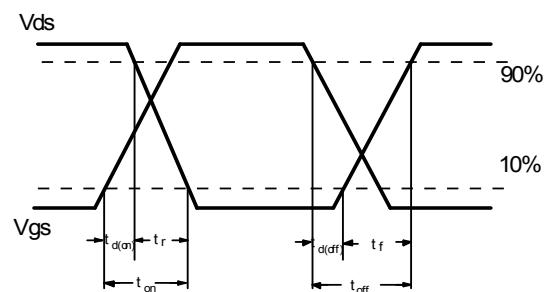
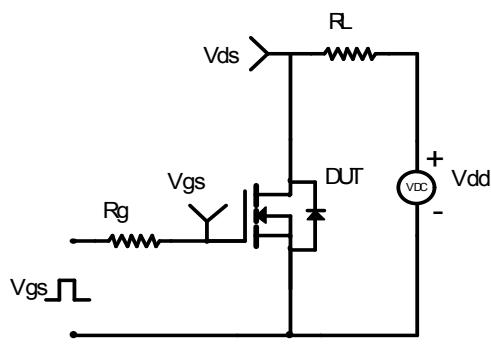
**TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS**


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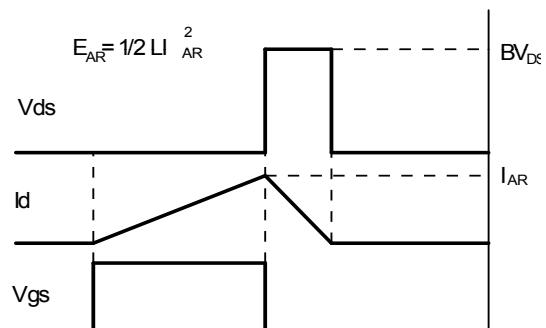
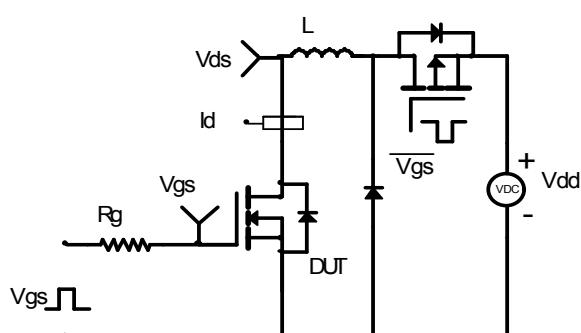
Gate Charge Test Circuit &amp; Waveform



Resistive Switching Test Circuit &amp; Waveforms



Unclamped Inductive Switching (UIS) Test Circuit &amp; Waveforms



Diode Recovery Test Circuit &amp; Waveforms

